

Received March 17, 2019, accepted March 27, 2019, date of publication March 29, 2019, date of current version June 4, 2019.

Digital Object Identifier 10.1109/ACCESS.2019.2908340

# Transverse Spurious Mode Compensation for AlN Lamb Wave Resonators

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**ABSTRACT** Lamb wave modes with type I dispersion characteristics exhibit strong affinity toward multi transverse modes behavior above resonance frequency ( $f_r$ ) in the AlN Lamb wave resonators (LWRs), especially the high-transduction-efficiency modes:  $S_0$  and  $S_1$  mode. For conventional interdigital transducer (IDT) design, the IDT aperture and IDT gap are the two main factors impacting the transverse mode placements and strengths, according to the wave vector analysis and finite element method (FEM) simulation. Moreover, the convex slowness curve of the Lamb wave modes propagating in AlN platelets allows the waveguiding and weak lateral leakage into busbars by the high-velocity IDT gap region. Apodization, the standard technique to suppress the transverse modes for IDT-excited resonators, suffers from drawbacks, such as additional loss and reduction of the effective coupling coefficient ( $k_{eff}^2$ ). Type I Lamb wave modes in AlN show positive slope in the dispersion branch so that a border region of lower Eigen-resonance frequency is required to form piston mode structure for transverse spurious mode suppression and lateral leakage reduction. Based on dispersion calculations and 2.5D FEM simulations, we demonstrate that by designing the low-velocity border region, such as simply changing the IDT layout, the guiding can be improved and a piston mode can be obtained for the type I Lamb wave modes.

**INDEX TERMS** Aluminum nitride, dispersion, lamb wave,  $S_0$  mode,  $S_1$  mode, transverse modes, piston mode structure.

## I. INTRODUCTION

Piezoelectric microelectromechanical (MEMS) resonators offer fascinating prospects for frequency selection, control, and sensing applications thanks to its small size and low resonance impedance. Among various piezo-MEMS resonators, AlN Lamb wave resonators (LWRs) recently capture attention since they enjoys both advantages of surface acoustic wave (SAW) devices and film bulk acoustic resonators (FBARs): the multi-frequency and CMOS-compatible ability [1]–[16]. For all Lamb wave modes propagating in an AlN plate, the  $S_0$  and  $S_1$  mode stand out for their excellent transduction efficiency [17], [17]–[24].

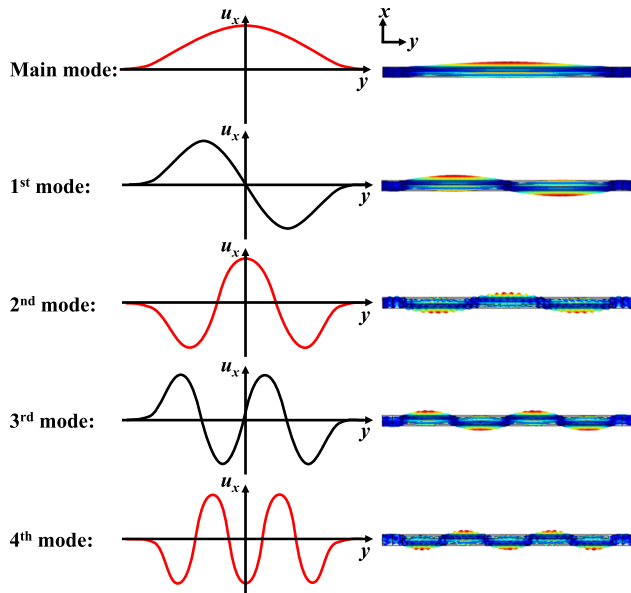
In general, high quality factor ( $Q$ ), large  $k_{eff}^2$ , high frequency ability and spurious free are the four most desirable fundamental aspects for micro resonators to enable low-loss filters, stable oscillators and sensitive sensors. While the  $S_0$  and  $S_1$  Lamb wave resonators excellently address the former three, they exhibit strong affinity toward multimode behavior near the main resonance mode along with their

superior transduction efficiency. The presence of the strong transverse modes across the lateral direction would hinder the accuracy and stability of oscillators and sensors, as well as hurt the performance of acoustic filters by creating severe passband ripples and potentially limiting the rejection [25]–[43].

The transverse modes show standing wave characteristics in lateral direction and has been intensively studied for SAW and FBARs [34], [44]. In LWRs, these unwanted modes are present in the passband with relatively large aperture and are due to the poor wave-guiding properties of the IDT strips [25]. Generally, the even modes have an extra half wavelength of the sinusoidal amplitude profile leading to non-vanishing coupling in the frequency response. As a contrast, the amplitudes in opposite directions equal and the electrode signal cancel out for the odd modes intrinsically. Fig. 1 shows the displacement profile in  $x$  (propagation) direction and the mode shapes for the transverse modes in AlN LWRs.

Apodization as a standard solution for transverse modes in the IDT-excited devices by varying the resonance cavity length to smooth out the effect of transverse mode on

The associate editor coordinating the review of this manuscript and approving it for publication was Yuhao Liu.



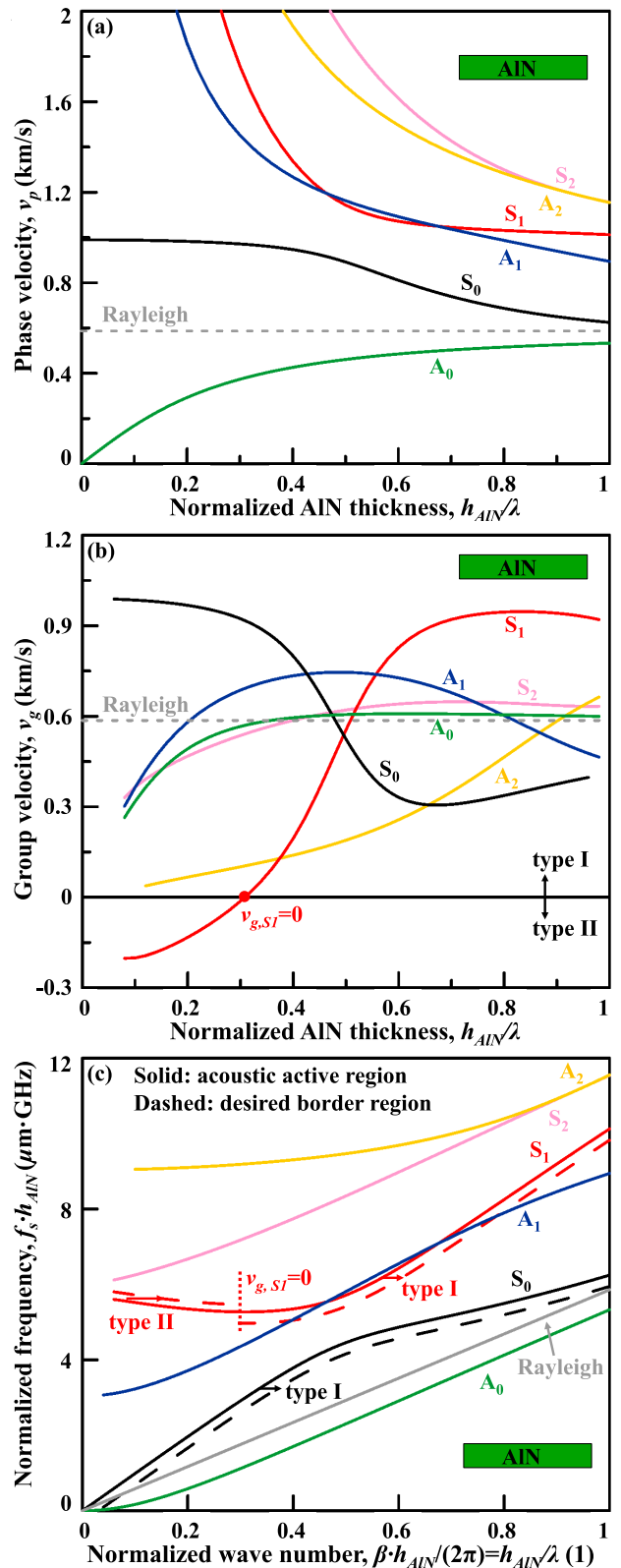
**FIGURE 1.** The displacement profile in  $x$  (propagation) direction  $u_x$  and the mode shapes for the transverse modes in AlN LWRs.

the electrical response, its incomplete transduction from the electrical field to main mode resonance results in substantial drawbacks such as reduction of the transduction efficiency and additional losses for both SAW filters [31] and Lamb wave resonators [45]. A better solution can be borrowed from the SAW and FBAR devices: by creating a border region with different frequency from active region according to the mode dispersion characteristic, a Piston mode structure can be obtained to cancel out the transverse wave vector in lateral direction without degrading the  $k_{eff}^2$  or  $Q$  [25], [31]–[46], when the waveguiding and the energy confinement effects optimized in the topology.

**II. DISPERSION CHARACTERISTICS OF LAMB WAVE MODES IN AlN**

The phase velocity ( $v_p$ ), group velocity ( $v_g$ ) and the dispersion curves ( $f$  - wave number ( $\beta$ )) of the first six Lamb wave modes are given in Fig. 2 (a), (b) and (c). The FEM Eigen-analysis is used in for an ideal infinite plate to get the open-surface phase velocity for each mode [3] and the group velocity derived from the  $v_p - \beta$  correlation. Fig. 2(a) shows that the fundamental Lamb wave modes  $A_0$  and  $S_0$  have weak dispersion characteristics (close to the Rayleigh mode), while the high-order Lamb wave modes are with steep dispersions. In IDT-excited device the wavelength  $\lambda$  ( $\lambda = 2\pi/\beta$ ) equals 2 times IDT pitch.

As can be seen from Fig. 2(b), evidently, almost all Lamb wave modes exhibit positive  $v_g$  except the  $S_1$  mode at  $h_{AlN}/\lambda < 0.3$ , where as a rare case, the energy of the  $S_1$  Lamb wave mode would travel inside to the transducers. Accordingly, as shown in Fig. 2 (c): the  $S_0$  mode exhibits positive slope through all wave number range, meaning the



**FIGURE 2.** (a) Phase velocity and (b) group velocity of the first six Lamb wave modes propagating in AlN plate. (c) Dispersion curves for the first six Lamb wave modes and the desired border region eigen-frequencies for  $S_0$  and  $S_1$  modes.

positive  $v_g$ ; the  $S_1$  mode has a negative group velocity at  $h_{AlN}/\lambda < 0.3$  and positive slope at  $h_{AlN}/\lambda > 0.3$ . Generally, the wave mode with positive  $v_g$  is referred to as type I dispersion, and the wave mode with negative  $v_g$  is referred to as with type II dispersion. As a result, the  $S_0$  mode corresponds to type I dispersion through all wave number range; the type II dispersion happens to the  $S_1$  mode at  $h_{AlN}/\lambda < 0.3$  and type I dispersion occurs at  $h_{AlN}/\lambda > 0.3$ .

To form Piston mode structure, for resonances of type I dispersion, the frequency of the border region must be lower than that of the active area, which is the similar case for ZnO FBAR [34], solidly mounted resonators (SMRs) [37] and SAW filters (non-dispersive Rayleigh wave or SH wave has positive dispersion slope of  $2\pi \bullet v_p$ ). On the contrary, for resonances of type II dispersion, the frequency of the border region must be higher than that of the active area, which is the case for AlN FBAR [35]. The dashed lines in Fig. 2(c) show the desired eigen-frequencies for the border region in order for the Piston mode to happen to the  $S_0$  and  $S_1$  modes.

Fig. 3 (a) and (b) show the simulated frequency response of the type I  $S_0$  mode and type II  $S_1$  mode, respectively. As expected, the transverse modes for the type I Lamb wave modes would occur above resonance frequency  $f_r$ , while for the type II Lamb wave mode the transverse modes take place below the  $f_r$ . In addition, for the LWR employing  $S_1$  mode in the type II region, the transverse modes are not strongly excited, and some other spurious modes, such as the inter-reflection from IDT fingers due to negative group velocity, are much stronger and more of concern (Fig. 3(b)). As a result, the transverse modes and the design of Piston mode for type I Lamb wave modes are emphatically discussed herein.

### III. TRANSVERSE MODES IN TYPE I LAMB WAVE MODES

The transverse modes and transverse leakage are sensitive to the lateral acoustic field distribution and controlled by the IDT designs. Similar to SAW resonators, the IDT aperture dominates the frequency locations of the transverse modes, which can be calculated by the superposition of wave vectors in longitudinal (propagation) and lateral (transverse) directions, according to the standing wave theory. The convex slowness curve of the Lamb wave modes propagating in AlN platelets allows weak lateral leakage for the LWRs with the high-velocity IDT gap regions.

#### A. IDT APERTURE

The standing wave nature of the transverse modes allows for direct derivation of their frequency allocations [43], [46], [47]. Intuitively, in lateral direction, the wave number is determined by the IDT aperture and transverse mode order:

$$\beta_y = \frac{\pi \cdot (n + 1)}{w_a}, \quad (1)$$

where the  $w_a$  represents the active region width or aperture width and  $n$  stands for the transverse mode order. The wave

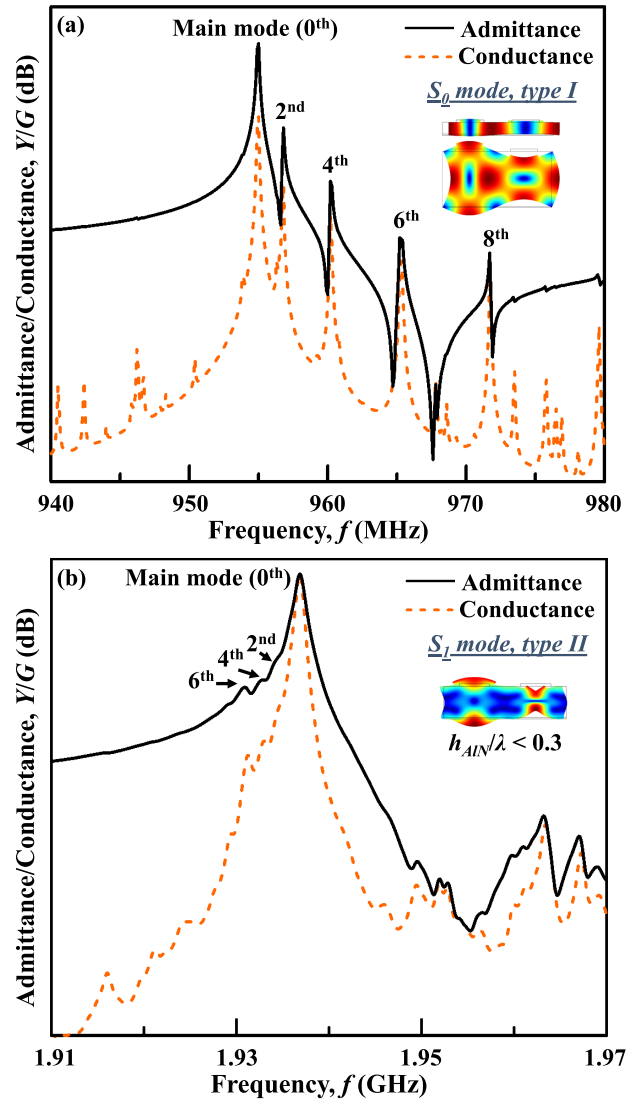


FIGURE 3. The simulated frequency response of the (a)  $S_0$  Lamb wave mode with type I dispersion and (b)  $S_1$  Lamb wave mode with type II dispersion when  $h_{AlN}/\lambda < 0.3$ .

number in propagation direction stays unchanged:

$$\beta_x = \frac{2\pi}{\lambda}. \quad (2)$$

Using orthogonal wave vector superposition, the wave number value of the  $n$ -th transverse mode can be estimated as:

$$\begin{aligned} \beta_{n,trans} &= 2\pi \sqrt{\left(\frac{n+1}{2 \cdot w_a}\right)^2 + \left(\frac{1}{\lambda}\right)^2} \\ &= \frac{2\pi}{\lambda} \sqrt{\left(\frac{\lambda}{2 \cdot w_a}\right)^2 (n+1)^2 + 1} \end{aligned} \quad (3)$$

By the first-order Taylor expansion, the offset of wavenumber from the ideal wave propagating only in  $x$  direction is:

$$\Delta\beta = \beta_{n,trans} - \beta_x = \frac{\pi}{4\lambda} \left(\frac{\lambda}{w_a}\right)^2 (n+1)^2 \quad (4)$$

Substituting the group velocity definition into the first order approximation:

$$\begin{aligned}
 f_{n,trans} &\cong f_{ideal} + \Delta\beta \bullet \frac{\partial f}{\partial \beta} = f_{ideal} + \Delta\beta \bullet v_g \\
 &\cong f_{ideal} + \frac{\pi}{4\lambda} \left(\frac{\lambda}{w_a}\right)^2 (n+1)^2 \bullet v_g, \quad (5)
 \end{aligned}$$

where  $f_{ideal}$  corresponds to the main resonance mode when the IDT aperture is infinitely long and the wave propagates in  $x$  direction only ( $\beta_{ideal} = \beta_x, \beta_y = 0$ ). It should be noted that in the case of main mode ( $n = 0$ ) when the IDT aperture is finite, the  $f_{r,main}$  is also deviated from  $f_{ideal}$  due to the lateral displacement localization. Regardless of the sign of  $v_g$ , it can be found that the larger the order  $n$ , the farther the transverse mode away from the main mode.

Recalling  $v_g > 0$  for type I dispersion and  $v_g < 0$  for type II dispersion, the frequency placements of transverse modes are at opposite locations comparing to the main mode:

$$\begin{aligned}
 \text{Type I : } f_{n,trans} &> f_{ideal} \approx f_{s,main} \\
 \text{Type II : } f_{n,trans} &< f_{ideal} \approx f_{s,main} \quad (6)
 \end{aligned}$$

For the type I modes, the transverse modes appear above the  $f_r$  of main mode and locate in the upper half of the smith chart; for the type II modes the transverse spurious is at lower frequency than  $f_r$  and represents resonating circles on the southwest of smith chart. This corresponds to the transverse modes location in Fig. 3 (a) and (b).

The fundamental modes  $A_0$  and  $S_0$  have weak dispersion, with dispersion curve  $\beta$ - $f$  close to the linear line of Rayleigh mode. For the  $S_0$  mode, the frequencies of transverse resonances can be further approximated by ignoring the dispersion at the localized wave number  $\beta$  and assuming  $v_p = v_g$ :

$$\begin{aligned}
 f_{n,trans} &\approx f_{ideal} + \frac{\pi}{4\lambda} \left(\frac{\lambda}{w_a}\right)^2 (n+1)^2 \cdot v_p \\
 &= f_{ideal} \left(1 + \frac{\pi}{4} \left(\frac{\lambda}{w_a}\right)^2 (n+1)^2\right). \quad (7)
 \end{aligned}$$

Fig. 4(a) shows the theoretical relation between the frequency placements of the  $n$ -th transverse modes and IDT aperture by formula (7) in lines and the FEM simulated cases in dots for the type I  $S_0$  Lamb wave mode. Fig. 4(b) depicts the FEM simulated frequency response for different normalized aperture length. Evidently, the longer the normalized active region  $w_a/\lambda$ , the more transverse mode will be in passband, as the wider displacement profile in transverse direction impact less on the overall wave number and thus pulls in each transverse mode to the main mode. The amplitude of each transverse resonance becomes weaker at longer aperture because of the inter energy dissipation for the closely allocated resonances [47]. Another phenomenon can be observed is for the main mode itself, that the  $k_{eff}^2$  will degrade for too-short aperture ( $w_a < 10\lambda$ ) as the transversal wave vector contributes to the wave vector of the main mode and diffraction takes place, which corresponds to the previous discussion on the definition of  $f_{ideal}$  and  $f_{r,main}$  (for this case of type I dispersion  $f_{r,main} > f_{ideal}$ ). In Fig. 4 (a), the FEM

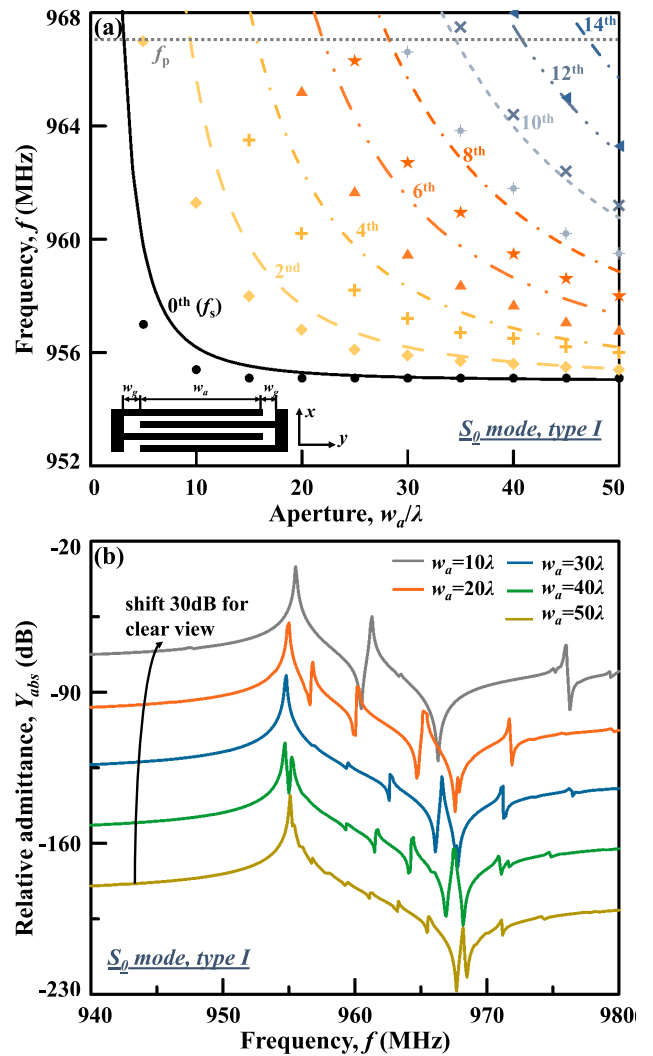


FIGURE 4. Spectra of the theoretical transverse spurious resonances as a function of aperture width  $w_a$  in lines and FEM simulated cases in dots. (b) FEM simulated frequency response for different normalized aperture lengths  $w_a$ .

simulated frequencies are lower than theoretical because the inactive regions such as busbar and gap are taken into account.

### B. IDT GAP

Fig. 5 shows the slowness curves of the transducer region, gap region, and busbar region of the  $S_0$  mode for the  $h_{AIN}/\lambda = 0.1$  case as an example. Aluminum is used for IDT and the thickness is assumed to  $0.08\lambda$  herein. The  $\theta$  monotonically increases with frequency for the transducer, busbar, and gap regions, meaning that the  $S_0$  Lamb wave exhibits convex slowness curve feature in all regions.

Usually for a wave with a convex slowness curve to be trapped, a faster region is required at the lateral end to guide the wave [47]. For TCSAW resonators on  $\text{SiO}_2/\text{LiNbO}_3$ , the faster gap region helps trapping energy, and for Quartz resonators the faster busbar region does the guiding job [31].

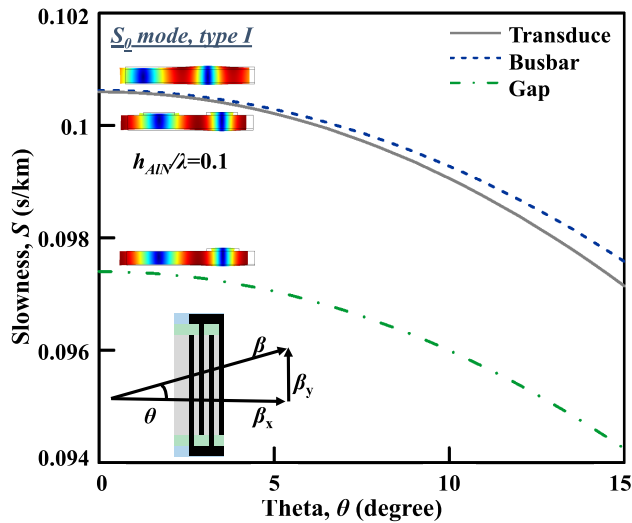


FIGURE 5. Slowness curve of the transducer region, gap region, and busbar region for the  $S_0$  mode in AlN.

In LWRs, it can be easily found that the  $S_0$  velocity in the busbar is lower than the  $S_0$  velocity in the transducer caused mostly by the smaller mass loading of the transducer strips as compared to the busbar [25]. However for the  $S_0$  mode here, the gap region exhibits too high phase velocity to make the wave guiding right at the transducer/gap interface. Also as the busbar region has phase velocity close to the transducer region, the wave guiding is actually close to the busbar/gap interface. As a result, by modifying the gap region width  $w_g$  the energy trapping would not be impact much. Unlike the TCSAW who has a larger  $Q$  for wider gap, the energy loss of  $S_0$  Lamb wave resonator is not dependent on the gap width; rather, the gap width has direct impact on the transverse mode amplitude.

Fig. 6 depicts the simulated conductance and mechanical quality factor of  $S_0$  resonators with different gap widths using perfectly matched layer (PML) - based FEM. In the acoustic  $Q$  calculation, an isotropic mechanical damping of 0.0003 is applied with PML on the ends of the periodic 2.5D structure, as shown in the inset of Fig. 6 (b). The  $Q$ 's are automatically computed by COMSOL Multiphysics indicating the number of cycles in which total energy of the system decreases by a factor of  $e^{2\pi}$  and the resistance is not considered herein.

The frequencies of the transverse modes lowered when the gap become wider, because the gap region “stretches” the active area a little bit so that the effective length of active part  $w_a$  becomes slightly larger. Unlike the  $\text{SiO}_2/\text{LiNbO}_3$ -based TCSAW using Rayleigh wave who also has a convex slowness curve characteristic and its high-velocity gap region provides the wave guiding, the  $Q$ 's of Lamb wave aren't pronouncedly improved by wider gap when  $w_g/\lambda$  increases from 1 to 3 (Fig. 6(b)). However, when the fast gap region is completely taken off and  $w_g = 0$ , the acoustic energy of the main mode does leak to the low-velocity busbar region (inset of Fig. 6(b)) and the  $Q_s$  of the main

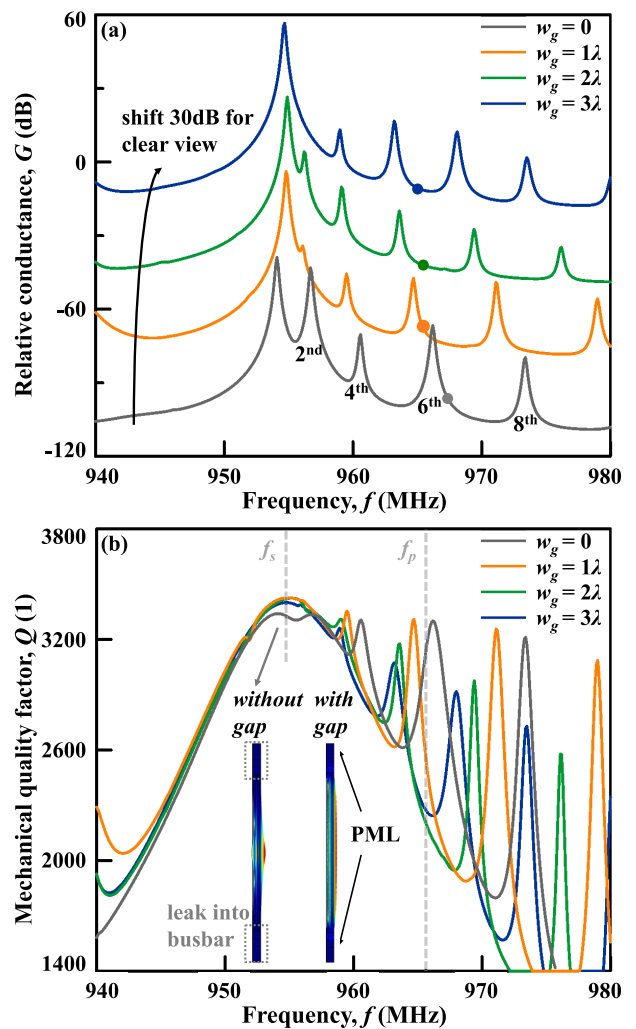


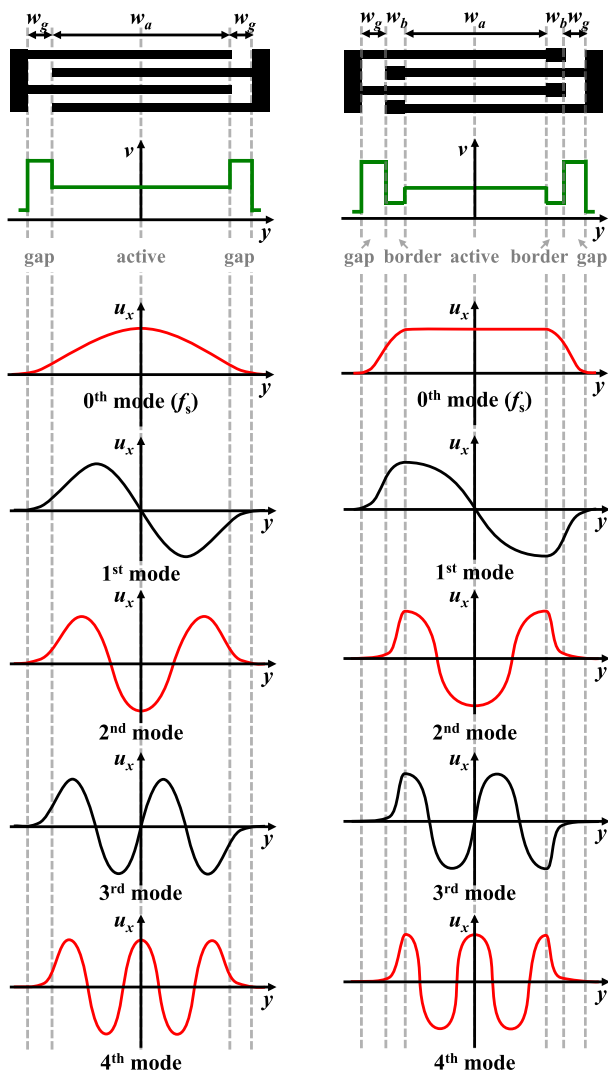
FIGURE 6. Comparison of the FEM simulated (a) conductance and (b) mechanical quality factor with different normalized gap width  $w_g$ .

mode lowered by the lateral penetration, indicating the wave guiding function provided by the fast region.

#### IV. PISTON MODE DESIGN FOR TYPE I LAMB WAVE MODES

##### A. PISTON MODE DESIGN FOR TYPE I LAMB WAVE MODES

For the type I modes, by adding a small border region with a slow velocity on the edge of the acoustic active region, a propagating mode has a zero transverse wave vector in the active aperture. The transverse wave vectors are real in the border region and imaginary on the gap region. Fig. 7 also compares the displacement profiles  $u_{x,n}$  of the  $n^{\text{th}}$  transverse mode in a traditional resonator and  $u_{x,n}$  of the resonator employing Piston mode. In the Piston mode structure - single mode waveguide, the effective coupling of the main mode is maximized and the displacement is at the maximum value in all active regions. In terms of the high order transverse modes, for the traditional resonator, approximately an extra half wave

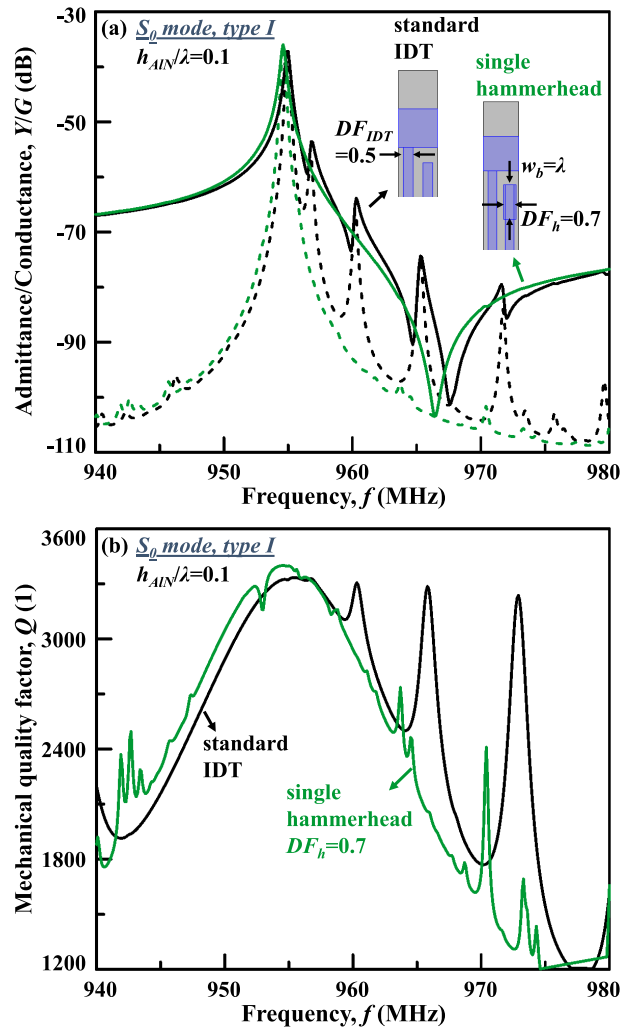


**FIGURE 7.** Comparison of the velocity profiles  $v$  and the displacement profiles  $u_{x,n}$  for the type I Lamb wave modes in (a) a traditional resonator and (b) transverse spurious resonance free resonators employing Piston mode structure by the design using IDT hammerhead.

lengths fits to the active region for all even modes leading to non-vanishing coupling, while for the Piston mode, the even order modes which have a multiple of full wave lengths in the active region, cancel each other and do not couple to electrical domain.

To be noted that because of the convex slowness curve of the Lamb wave modes in AIN (Fig. 5), usually the IDT dummy electrodes are not need for the energy trapping in the lateral field, which simplifies the problem [31].

There are several ways of designs to create the slow border region and thus achieve the Piston mode structure borrowed from SAW and BAW designs, including: (i) changing the duty factor of IDT electrodes at IDT ends, (ii) adding electrode metal thickness at IDT ends, (iii) adding low-velocity dielectric layer at the border region, (iv) adding high-velocity dielectric layer at the non-border active region, and (v) adding



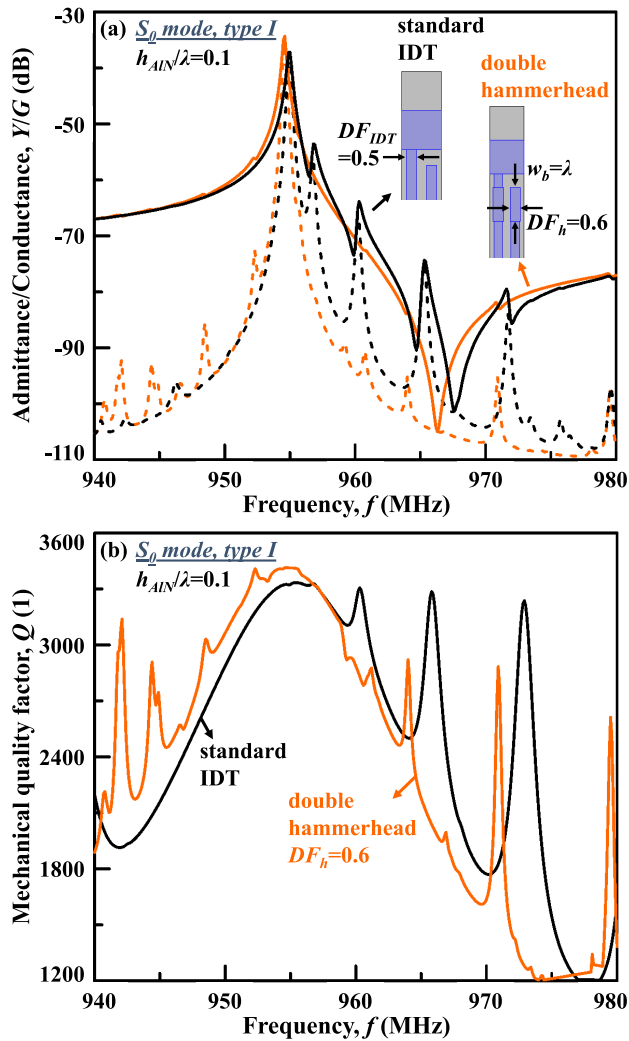
**FIGURE 8.** Comparison of the FEM simulated (a) frequency response and (b) mechanical  $Q$  for the  $S_0$  mode employing conventional IDT and single hammerhead IDT with  $DF_h = 0.7$  forming Piston mode structure.

AIN mass extrudes at the sides or bottom of the AIN plate to form the border regions.

The easiest implementation of (i) consists in using larger metal coverage ratio electrode – the “hammerhead” in the border region. The proposed hammerhead IDT is shown in Fig. 7 as an example.

**B. FEM DEMONSTRATION**

Figs. 8, and 9 show the FEM simulated frequency response and Bode  $Q$  curves for the type I  $S_0$  mode employing regular IDT and two types of hammerhead IDT forming the Piston mode waveguide. The optimized design yield a duty factor of the hammerhead ( $DF_h$ ) of 0.7 for the single hammerhead case and a  $DF_h$  of 0.6 for the double hammerhead case. By carefully designing the metal ratio  $DF_h$  in corresponds to the slower border region phase velocity ( $v_b$ ) together with the border width  $w_b$ , the relative coupling coefficients of transverse modes are reduced to a negligible level and amplitudes of the transverse modes in the type I  $S_0$  are



**FIGURE 9.** Comparison of the FEM simulated (a) frequency response and (b) mechanical  $Q$  for the  $S_0$  mode employing conventional IDT and double hammerhead IDT with  $DF_h = 0.6$  forming Piston mode.

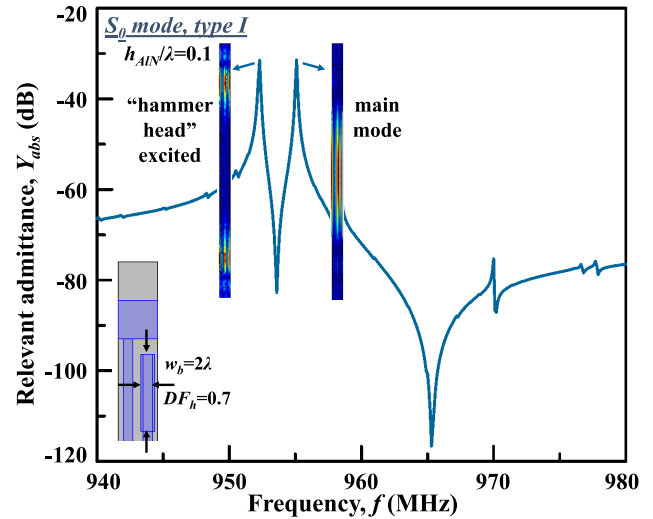
effectively reduced, or even eliminated in electrical response. In addition, the  $Q$  of the main mode is also improved by the reduction of transverse leakage, which is one of the main steps to achieve a high- $Q$  resonator [30].

The desired border region width  $w_b$  and border region phase velocity  $v_b$  are the two main design variants for Piston mode structure. The values can be calculated by assuming small difference between the phase velocities as in [31] and fine-tuned based on the exact structure. Their relation can be written as:

$$\frac{w_b}{\lambda} \propto \frac{\Delta g}{\sqrt{\Delta b}}, \quad (8)$$

where  $\Delta b$  and  $\Delta g$  are the relative difference between the phase velocities of active region ( $v_a$ ), gap region ( $v_g$ ), and border region ( $v_b$ ):

$$\begin{aligned} v_b &= v_a(1 - \Delta b) \\ v_g &= v_a(1 + \Delta g) \end{aligned} \quad (9)$$



**FIGURE 10.** FEM simulated admittance for a Piston-mode-structure device with a border region width  $w_b$  too large.

It should be noted that the desired border region  $w_b/\lambda$  is not dependent on the aperture  $w_a/\lambda$ , rather dominated by the phase velocity differences.

Fig. 10 shows the admittance of a  $S_0$  mode resonator when the width of the border region is too large. In this case, the hammerhead no longer just works as the wave field modification region, but as the transducer itself. Thus, another resonance is excited by the hammerhead at frequency slightly lower than the main mode due to the larger duty factor, making the response split into two resonance peaks. As shown in the inset of Fig. 10, the resonance displacement of the first peak happens right at the hammerhead region and for the main mode the effective active region is reduced to  $(w_a - 2w_b)$ .

Similar to the  $S_0$  mode case, this Piston mode design can be applied to other Type I Lamb wave modes for the transverse mode compensation and loss reduction.

## V. CONCLUSION

For AlN Lamb wave devices, the transverse modes are strong in the large- $k_{eff}^2$  type I modes, which deteriorate the device performance greatly by the occurrence of unwanted spurious resonances and the additional transversal loss. The dispersion characteristics for the first six Lamb wave modes are calculated: except for partial of the  $S_1$  mode, most Lamb wave modes exhibit positive  $v_g$  and type I dispersion. By wave vector analysis and FEM simulations, the active region width  $w_a$  is found to determine the frequencies of transverse modes directly. The slowness curve indicates that the gap region guides the Lamb wave and prevents acoustic penetration into the slow busbar region, which is also demonstrated by FEM simulation. The Piston mode structure for type I Lamb wave modes created by adding a slow border region at the edge of the active aperture can eliminate the transverse modes and yet does not introduce performance degradations of the main mode. The FEM simulated AlN  $S_0$  and type I  $S_1$  mode

LWRs using simply hammerhead enabling the Piston mode exhibit spurious free operation. These spurious free, high  $Q$ , and large  $k_{\text{eff}}^2$  LWRs enable the construction of single-chip filters, oscillators and sensors with superior performance characteristics.

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